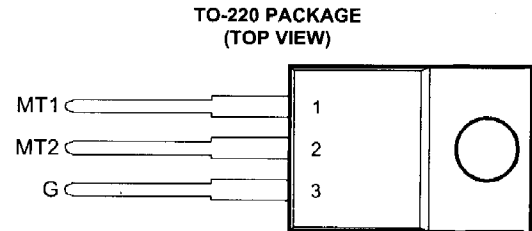


- 8 A RMS, 70 A Peak
- Glass Passivated Wafer
- 400 V to 800 V Off-State Voltage
- Max  $I_{GT}$  of 50 mA (Quadrants 1 - 3)



Pin 2 is in electrical contact with the mounting base.

**absolute maximum ratings over operating case temperature (unless otherwise noted)**

RATING		SYMBOL	VALUE	UNIT
Repetitive peak off-state voltage (see Note 1)	TIC226D	$V_{DRM}$	400	V
	TIC226M		600	
	TIC226S		700	
	TIC226N		800	
Full-cycle RMS on-state current at (or below) 85°C case temperature (see Note 2)		$I_{T(RMS)}$	8	A
Peak on-state surge current full-sine-wave (see Note 3)		$I_{TSM}$	70	A
Peak on-state surge current half-sine-wave (see Note 4)		$I_{TSM}$	80	A
Peak gate current		$I_{GM}$	±1	A
Peak gate power dissipation at (or below) 85°C case temperature (pulse width ≤ 200 μs)		$P_{GM}$	2.2	W
Average gate power dissipation at (or below) 85°C case temperature (see Note 5)		$P_{G(AV)}$	0.9	W
Operating case temperature range		$T_C$	-40 to +110	°C
Storage temperature range		$T_{stg}$	-40 to +125	°C
Lead temperature 1.6 mm from case for 10 seconds		$T_L$	230	°C

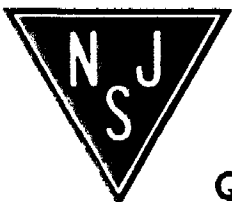
- NOTES: 1. These values apply bidirectionally for any value of resistance between the gate and Main Terminal 1.  
 2. This value applies for 50-Hz full-sine-wave operation with resistive load. Above 85°C derate linearly to 110°C case temperature at the rate of 320 mA/°C.  
 3. This value applies for one 50-Hz full-sine-wave when the device is operating at (or below) the rated value of on-state current. Surge may be repeated after the device has returned to original thermal equilibrium. During the surge, gate control may be lost.  
 4. This value applies for one 50-Hz half-sine-wave when the device is operating at (or below) the rated value of on-state current. Surge may be repeated after the device has returned to original thermal equilibrium. During the surge, gate control may be lost.  
 5. This value applies for a maximum averaging time of 20 ms.

**electrical characteristics at 25°C case temperature (unless otherwise noted)**

PARAMETER	TEST CONDITIONS			MIN	TYP	MAX	UNIT
$I_{DRM}$ Repetitive peak off-state current	$V_D = \text{rated } V_{DRM}$	$I_G = 0$	$T_C = 110^\circ\text{C}$			±2	mA
$I_{GTM}$ Peak gate trigger current	$V_{supply} = +12\text{ V}\dagger$	$R_L = 10\ \Omega$	$t_{p(g)} > 20\ \mu\text{s}$		2	50	mA
	$V_{supply} = +12\text{ V}\dagger$	$R_L = 10\ \Omega$	$t_{p(g)} > 20\ \mu\text{s}$		-12	-50	
	$V_{supply} = -12\text{ V}\dagger$	$R_L = 10\ \Omega$	$t_{p(g)} > 20\ \mu\text{s}$		-9	-50	
	$V_{supply} = -12\text{ V}\dagger$	$R_L = 10\ \Omega$	$t_{p(g)} > 20\ \mu\text{s}$		20		
$V_{GTM}$ Peak gate trigger voltage	$V_{supply} = +12\text{ V}\dagger$	$R_L = 10\ \Omega$	$t_{p(g)} > 20\ \mu\text{s}$		0.7	2	V
	$V_{supply} = +12\text{ V}\dagger$	$R_L = 10\ \Omega$	$t_{p(g)} > 20\ \mu\text{s}$		-0.8	-2	
	$V_{supply} = -12\text{ V}\dagger$	$R_L = 10\ \Omega$	$t_{p(g)} > 20\ \mu\text{s}$		-0.8	-2	
	$V_{supply} = -12\text{ V}\dagger$	$R_L = 10\ \Omega$	$t_{p(g)} > 20\ \mu\text{s}$		0.9	2	

† All voltages are with respect to Main Terminal 1.

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# TIC226 SERIES SILICON TRIACS

electrical characteristics at 25°C case temperature (unless otherwise noted) (continued)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$V_{TM}$	Peak on-state voltage $I_{TM} = \pm 12 \text{ A}$ $I_G = 50 \text{ mA}$ (see Note 6)		$\pm 1.6$	$\pm 2.1$	V
$I_H$	Holding current $V_{supply} = +12 \text{ V} \dagger$ $I_G = 0$ Init' $I_{TM} = 100 \text{ mA}$ $V_{supply} = -12 \text{ V} \dagger$ $I_G = 0$ Init' $I_{TM} = -100 \text{ mA}$		5 -9	30 -30	mA
$I_L$	Latching current $V_{supply} = +12 \text{ V} \dagger$ (see Note 7) $V_{supply} = -12 \text{ V} \dagger$			50 -50	mA
dv/dt	Critical rate of rise of off-state voltage $V_{DRM} = \text{Rated } V_{DRM}$ $I_G = 0$ $T_C = 110^\circ\text{C}$		$\pm 100$		V/ $\mu\text{s}$
dv/dt <sub>(c)</sub>	Critical rise of commutation voltage $V_{DRM} = \text{Rated } V_{DRM}$ $I_{TRM} = \pm 12 \text{ A}$ $T_C = 85^\circ\text{C}$	$\pm 5$			V/ $\mu\text{s}$

† All voltages are with respect to Main Terminal 1.

NOTES: 6. This parameter must be measured using pulse techniques,  $t_p \leq 1 \text{ ms}$ , duty cycle  $\leq 2\%$ . Voltage-sensing contacts separate from the current carrying contacts are located within 3.2 mm from the device body.

7. The triacs are triggered by a 15-V (open-circuit amplitude) pulse supplied by a generator with the following characteristics:  
 $R_G = 100 \Omega$ ,  $t_{p(g)} = 20 \mu\text{s}$ ,  $t_r \leq 15 \text{ ns}$ ,  $f = 1 \text{ kHz}$ .

## thermal characteristics

PARAMETER	MIN	TYP	MAX	UNIT
$R_{\theta JC}$ Junction to case thermal resistance			1.8	$^\circ\text{C/W}$
$R_{\theta JA}$ Junction to free air thermal resistance			62.5	$^\circ\text{C/W}$

## TYPICAL CHARACTERISTICS

